


<b>Search Notes</b>  	<b>Application/Control No.</b>  10535436	<b>Applicant(s)/Patent Under Reexamination</b>  STORKEL ET AL.
	<b>Examiner</b>  RANDALL CHIN	<b>Art Unit</b>  3723

SEARCHED			
Class	Subclass	Date	Examiner
15	143.1	3/16/09	AG
updated search		2/22/11	RC
updated search		6/3/11	RC

SEARCH NOTES		
Search Notes	Date	Examiner
Conducted Text Search and Inventor Search	3/16/09	AG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--